
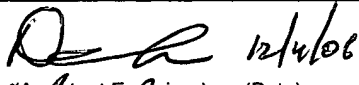

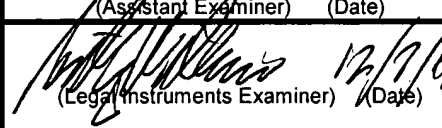


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/099,875	YU ET AL.	
	Examiner	Art Unit	
	David Lee	2613	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
398		152							
INTERNATIONAL CLASSIFICATION									
H	0	4	B	10/00					
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				/					

 (Assistant Examiner) (Date)		 <b>JASON CHAN</b> SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2600 (Primary Examiner) (Date)		Total Claims Allowed: 15	
 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 3	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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